

<b>PCN Number:</b>	20210720000.1	<b>PCN Date:</b>	July 22, 2021
<b>Title:</b>	Qualification of new Fab site (RFAB) using qualified Process Technology, Die Revision, Datasheet update and additional Assembly site/BOM options for select devices		
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>	<b>Dept:</b>	Quality Services
<b>Proposed 1<sup>st</sup> Ship Date:</b>	Oct 22, 2021	<b>Estimated Sample Availability:</b>	Date provided at sample request.
<b>Change Type:</b>			
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process
<input checked="" type="checkbox"/>	Design	<input checked="" type="checkbox"/>	Electrical Specification
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material
<input checked="" type="checkbox"/>	Wafer Fab Site	<input checked="" type="checkbox"/>	Wafer Fab Materials
		<input type="checkbox"/>	Part number change

### PCN Details

#### Description of Change:

Texas Instruments is pleased to announce the qualification of a new fab & process technology (RFAB, LBC7) and assembly (MLA) site/BOM options for selected devices as listed below in the product affected section.

Current Fab Site			New Fab Site		
Fab Site	Process	Wafer Diameter	Fab Site	Process	Wafer Diameter
DL-LIN	LBC3S	150 mm	RFAB	LBC7	300 mm
DL-LIN	LBC3S	200 mm			

The die was also changed as a result of the process change.

The datasheets will be changing as a result of the above mentioned changes. The datasheet change details can be reviewed in the datasheet revision history. The link to the revised datasheet is available in the table below.



**TRS3221E**  
SLLS792B – JUNE 2007 – REVISED JULY 2021

#### Changes from Revision A (December 2020) to Revision B (July 2021)

**Page**

- Changed the *Applications* list..... 1
- Changed the table note for the *ESD Ratings, IEC Specifications* to make it applicable to all packages..... 4
- Changed the thermal information for PW and DB packages..... 5



**TRSF3221E**  
SLLS822B – JULY 2007 – REVISED JULY 2021

#### Changes from Revision A (May 2021) to Revision B (July 2021)

**Page**

- Changed the *Applications* list..... 1
- Changed the table note for the *ESD Ratings - IEC Specifications* table to make it also applicable to PW package..... 4
- Changed the thermal information for PW package..... 5

**Changes from Revision B (March 2016) to Revision C (July 2021) Page**

- Changed the *Applications* list..... 1
- Added *ESD ratings IEC Specifications* table and added a table note for the minimum requirement to meet the IEC ESD level..... 4
- Changed values in the *Thermal Information* table for DB and PW packages..... 5

**Changes from Revision O (June 2015) to Revision P (July 2021) Page**

- Changed the *Applications* list..... 1
- Changed the values in the *Thermal Information* table for DB and PW packages..... 5

**Changes from Revision E (October 2004) to Revision F (July 2021) Page**

- Changed the *Applications* list..... 1
- Deleted the *Ordering Information* table..... 1
- Added the *Device Information* table..... 1
- Removed the thermal parameters from *Absolute Maximum Ratings* table and moved them to *Thermal Information* table..... 4
- Added *ESD Ratings* table. Moved the driver and receiver ESD specifications to this table..... 4
- Changed the thermal parameters for PW package of SN65C3221 and DB package of SN75C3221. Added additional thermal parameters for both the packages in the *Thermal Information* table..... 5
- Added the *Detailed Description* section..... 11

**Changes from Revision B (April 2009) to Revision C (July 2021) Page**

- Changed the *Applications* list..... 1
- Deleted the *Ordering Information* table..... 1
- Added the *Device Information* table..... 1
- Added the *Pin Configuration and Functions* ..... 4
- Removed the thermal information from *Absolute Maximum Rating*stable and moved the thermal information to its own table..... 5
- Added a table note for PW package of SN65C3221E regarding the minimum capacitance in *ESD Ratings - IEC Specifications* table..... 5
- Changed thermal information for PW package of SN65C3221E. Added additional thermal information for other packages..... 6
- Added the *Detailed Descriptio*n section..... 13

Product Folder	Current Datasheet Number	New Datasheet Number	Link to full datasheet
TRS3221E	SLLS792A	SLLS792B	<a href="http://www.ti.com/product/TRS3221E">http://www.ti.com/product/TRS3221E</a>
TRSF3221E	SLLS822A	SLLS822B	<a href="http://www.ti.com/product/TRSF3221E">http://www.ti.com/product/TRSF3221E</a>
MAX3221E	SLLS686B	SLLS686C	<a href="http://www.ti.com/product/MAX3221E">http://www.ti.com/product/MAX3221E</a>

MAX3221	SLLS3480	SLLS348P	<a href="http://www.ti.com/product/MAX3221">http://www.ti.com/product/MAX3221</a>
SN65C3221, SN75C3221	SLLS351E	SLLS351F	<a href="http://www.ti.com/product/SN65C3221">http://www.ti.com/product/SN65C3221</a>
SN65C3221E	SLLS694B	SLLS694C	<a href="http://www.ti.com/product/SN65C3221E">http://www.ti.com/product/SN65C3221E</a>

Construction differences are noted below:

**Group 1 MLA A/T site & BOM updates for PW Devices:**

	<b>ASESH</b>	<b>MLA</b>
Lead finish	Matte Sn	NiPdAu
Mount Compound	EY1000063	4147858
Mold Compound	EN2000508	4211471

Tube versions of the devices are included in EOL notice PDN# 20210720002.3.

Qual details are provided in the Qual Data Section.

**Reason for Change:**

These changes are part of our multiyear plan to transition products from our 150-millimeter factories to newer, more efficient manufacturing processes and technologies, underscoring our commitment to product longevity and supply continuity.

**Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):**

None

**Impact on Environmental Ratings:**

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

<b>RoHS</b>	<b>REACH</b>	<b>Green Status</b>	<b>IEC 62474</b>
<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change

**Changes to product identification resulting from this PCN:**

**Fab Site Information:**

Chip Site	Chip Site Origin Code (20L)	Chip Site Country Code (21L)	Chip Site City
DL-LIN	DLN	USA	Dallas
<b>RFAB</b>	<b>RFB</b>	<b>USA</b>	<b>Richardson</b>

**Die Rev:**

<b>Current</b>	<b>New</b>
Die Rev [2P]	<b>Die Rev [2P]</b>
D, -	<b>A</b>

**Assembly Site Information:**

Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City
ASESH	ASH	CHN	Shanghai
<b>TI Malaysia</b>	<b>MLA</b>	<b>MYS</b>	<b>Kuala Lumpur</b>

Sample product shipping label (not actual product label)

**TEXAS INSTRUMENTS**  
 MADE IN: Malaysia  
 2DC: 20:  
 MSL 2 /260C/1 YEAR SEAL DT  
 MSL 1 /235C/UNLIM 03/29/04  
 OPT:  
 ITEM: 39  
**LBL: 5A (L)T0:1750**

(1P) SN74LS07NSR  
 (Q) 2000 (D) 0336  
 (31T) LOT: 3959047MLA  
 (4W) TKY (1T) 7523483SI2  
 (P)  
 (2P) REV: (V) 0033317  
 (20L) CSO: SHE (21L) COO:USA  
 (22L) ASO: MLA (23L) ACO: MYS

**Product Affected:**

**Group 1 - RFAB/Process migration, Die Rev, Datasheet, MLA A/T site & BOM updates:**

MAX3221EIPWR	MAX3221IPWR
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**Group 2 - RFAB/Process migration, Die Rev & Datasheet changes:**

MAX3221CDBR	MAX3221ECPWR	MAX3221IPWRG4	TRS3221ECPWR
MAX3221CDBRG4	MAX3221EIDBR	SN65C3221EPWR	TRS3221EIDBR
MAX3221CPWR	MAX3221EIDBRG4	SN65C3221EPWRE4	TRS3221EIPWR
MAX3221CPWRE4	MAX3221EIPWRG4	SN65C3221PWR	TRSF3221ECPWR
MAX3221CPWRG4	MAX3221IDBR	SN65C3221PWRE4	TRSF3221EIPWR
MAX3221ECDBR	MAX3221IDBRE4	SN75C3221DBR	TRSF3221EIPWRG4
MAX3221ECDBRG4	MAX3221IDBRG4	TRS3221ECDBR	

**Qualification Report**  
**Approve Date 23-Jun-2021**

**Qualification Results**

**Data Displayed as: Number of lots / Total sample size / Total failed**

Type	Test Name / Condition	Duration	Qual Device: TRS3221EIPWR	QBS Process Reference: TPS51217DSQ	QBS Process Reference: TPS53605DSQ	QBS Package Reference: TMUX1308QPWRQ1
AC	Autoclave 121C	96 Hours	-	3/231/0	-	3/231/0
CDM	ESD - CDM	2000 V	1/3/0	-	-	1/3/0
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	3/2999/0	-
HAST	Biased HAST 130C/85%RH	96 Hours	-	3/231/0	-	3/231/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	3/231/0	-
HBM	ESD - HBM (All Pins)	3500 V	1/3/0	-	-	-
HBM	ESD - HBM (Pins 8, 13 only)	16000 V	1/3/0	-	-	-
HTOL	Life Test, 125C	1000 Hours	-	-	3/231/0	-
HTOL	Life Test, 135C	635 Hours	-	3/231/0	-	-
HTOL	Life Test, 150C	300 Hours	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	3/231/0	2/90/0	-

Type	Test Name / Condition	Duration	Qual Device: <u>TRS3221EIPWR</u>	QBS Process Reference: <u>TPS51217DSC</u>	QBS Process Reference: <u>TPS53605DSQ</u>	QBS Package Reference: <u>TMUX1308QPWRQ1</u>
HTSL	High Temp Storage Bake 175C	500 Hours	-	-	-	3/135/0
LU	Latch-up	( Per JESD78 )	1/6/0	-	-	-
TC	Temperature Cycle -65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	3/231/0	-
WBP	Bond Pull	Wires	1/76/0	-	3/228/0	3/90/0
WBS	Ball Bond Shear	Wires	1/76/0	-	3/228/0	3/90/0

- QBS: Qual By Similarity

- Qual Device TRS3221EIPWR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free (SMT) and Green

## Qualification Report Approve Date 23-Jun-2021

### Qualification Results

**Data Displayed as: Number of lots / Total sample size / Total failed**

Type	Test Name / Condition	Duration	Qual Device: <u>TRSF3221EIPWR</u>	QBS Process Reference: <u>TPS51217DSC</u>	QBS Process Reference: <u>TPS53605DSQ</u>	QBS Package Reference: <u>TMUX1308QPWRQ1</u>
AC	Autoclave 121C	96 Hours	-	3/231/0	-	3/231/0
CDM	ESD - CDM	2000 V	1/3/0	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	3/2999/0	-
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	3/231/0	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	-	3/231/0
HBM	ESD - HBM (All Pins)	3500 V	1/3/0	-	-	-
HBM	ESD - HBM (Pin 8,13)	16000 V	1/3/0	-	-	-
HTOL	Life Test, 125C	1000 Hours	-	-	3/231/0	-
HTOL	Life Test, 135C	635 Hours	-	3/231/0	-	-
HTOL	Life Test, 150C	300 Hours	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	3/231/0	2/90/0	-
HTSL	High Temp Storage Bake 175C	500 Hours	-	-	-	3/135/0
LU	Latch-up	( Per JESD78 )	1/6/0	-	-	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST	264 Hours	-	-	3/231/0	-

Type	Test Name / Condition	Duration	Qual Device: <u>TRSF3221EIPWR</u>	QBS Process Reference: <u>TPS51217DSC</u>	QBS Process Reference: <u>TPS53605DSQ</u>	QBS Package Reference: <u>TMUX1308QPWRQ1</u>
	110C/85%RH					
WBP	Bond Pull	Wires	1/76/0	-	3/228/0	3/90/0
WBS	Ball Bond Shear	Wires	1/76/0	-	3/228/0	3/90/0

- QBS: Qual By Similarity
- Qual Device TRSF3221EIPWR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
  - The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
  - The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles
- Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free (SMT) and Green

**Qualification Report**

**Approve Date 09-Jul-2021**

**Qualification Results**

**Data Displayed as: Number of lots / Total sample size / Total failed**

Type	Test Name / Condition	Duration	Qual Device: <u>TRS3221EIDBR</u>	QBS Product Reference: <u>TRS3221EIPWR</u>	QBS Process Reference: <u>TPS51217DSC</u>	QBS Process Reference: <u>TPS53605DSQ</u>	QBS Package Reference: <u>TL1454ACDBR</u>	QBS Package Reference: <u>TPD3S714QDBRQ1</u>
AC	Autoclave 121C	96 Hours	-	-	3/231/0	-	3/231/0	3/231/0
CDM	ESD - CDM	2000 V	1/3/0	-	-	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	-	3/2999/0	-	-
HAST	Biased HAST 130C/85%RH	96 Hours	-	-	3/231/0	-	-	3/231/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	-	3/231/0	-	-
HBM	ESD - HBM (All Pins)	3500 V	-	1/3/0	-	-	-	-
HBM	ESD - HBM (Pins 8, 13 only)	16000 V	-	1/3/0	-	-	-	-
HTOL	Life Test, 125C	1000 Hours	-	-	-	3/231/0	-	-
HTOL	Life Test, 135C	635 Hours	-	-	3/231/0	-	-	-
HTOL	Life Test, 150C	408 hours	-	-	-	-	-	3/231/0
HTSL	High Temp Storage Bake 175C	500 hours	-	-	-	-	-	3/135/0
HTSL	High Temp Storage Bake, 170C	420 Hours	-	-	3/231/0	2/90/0	3/227/0	-
LU	Latch-up	( Per JESD78 )	-	1/6/0	-	-	-	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	-	3/231/0	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	-	3/231/0	-	-
WBP	Bond Pull	Wires	1/76/0	1/76/0	-	3/228/0	-	3/228/0
WBS	Ball Bond Shear	Wires	1/76/0	1/76/0	-	3/228/0	-	3/90/0

- QBS: Qual By Similarity
- Qual Device TRS3221EIDBR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free (SMT) and Green



## Qualification Report

Approve Date 09-Jul-2021

### Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: TRSF3221EIDBR	QBS Product Reference: TRSF3221EIPWR	QBS Process Reference: TPS51217/DSC	QBS Process Reference: TPS53605DSQ	QBS Package Reference: TL1454ACDBR	QBS Package Reference: TPD3S714QDBQRQ1
AC	Autoclave 121C	96 Hours	-	-	3/231/0	-	3/231/0	3/231/0
CDM	ESD - CDM	2000 V	1/3/0	-	-	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	-	3/2999/0	-	-
HAST	Biased HAST 130C/85%RH	96 Hours	-	-	3/231/0	-	-	3/231/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	-	3/231/0	-	-
HBM	ESD - HBM (All Pins)	3500 V	-	1/3/0	-	-	-	-
-	ESD - HBM (Pin 8,13)	16000 V	-	1/3/0	-	-	-	-
HTOL	Life Test, 125C	1000 Hours	-	-	-	3/231/0	-	-
HTOL	Life Test, 135C	635 Hours	-	-	3/231/0	-	-	-
HTOL	Life Test, 150C	408 hours	-	-	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	3/231/0	2/90/0	3/227/0	-
LU	Latch-up	( Per JESD78 )	-	1/6/0	-	-	-	-
TC	Temperature Cycle - 65/150C	500 Cycles	-	-	3/231/0	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	-	3/231/0	-	-
WBP	Bond Pull	Wires	1/76/0	1/76/0	-	3/228/0	-	3/228/0
WBS	Ball Bond Shear	Wires	1/76/0	1/76/0	-	3/228/0	-	3/90/0

- QBS: Qual By Similarity

- Qual Device TRSF3221EIDBR is qualified at LEVEL1-260C

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free (SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
WW PCN Team	<a href="mailto:PCN_ww_admin_team@list.ti.com">PCN_ww_admin_team@list.ti.com</a>

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